## **AMENDMENTS TO THE CLAIMS:**

This listing of claims will replace all prior versions, and listings, of claims in the application:

## **LISTING OF THE CLAIMS:**

- 1. (Currently Amended) Article of manufacture comprising a substrate and a layer of  $N_{(x)}Y_{(1-x)}AlO_3$  on the substrate where x is a molar fraction greater than zero and less than one, and N is an element selected from the group consisting of La, Ce, Pr, Nd, Pm, Sm, Eu, Gd, Tb, Dy, Ho, Er, Tm, Yb, and Lu; and said layer has a rhombohedral perovskite structure.
- 2. (Original) Article as claimed in claim 1, wherein N comprises La.
- 3. (Cancelled)
- 4. (Currently Amended) Article as claimed in claim [[3]]1, wherein said layer has an average dielectric constant value in the range between 15 and 35.
- 5. (Original) Article as claimed in claim 2, wherein x is greater than 0.07.
- 6. (Original) Article as claimed in claim 5, wherein x is less than 0.4.
- 7. (Original) Article as claimed in claim 1, further comprising an electrode electrically isolated from said substrate by said layer.
- 8. (Original) Electronic device comprising an article as claimed in claim 7.
- 9. (Original) Field effect transistor device comprising an article as claimed in claim 7, wherein said electrode is the gate of a field effect transistor device.

- 10. (Currently Amended) Method of manufacturing an article of manufacture comprising the steps of selecting a substrate and forming a layer of  $N_{(x)}Y_{(1-x)}AlO_3$  on said substrate where x is a molar fraction greater than zero and less than one, and N is an element selected from the group consisting of La, Ce, Pr, Nd, Pm, Sm, Eu, Gd, Tb, Dy, Ho, Er, Tm, Yb, and Lu; and said layer has a rhombohedral perovskite structure.
- 11. (Original) Method of claim 10, wherein said step of forming includes the step of forming said layer by molecular beam epitaxy.
- 12. (New) Article of manufacture comprising a substrate and a layer of  $La_{(x)}Y_{(1-x)}AlO_3$  on the substrate where x is a molar fraction greater than zero and less than one.
- 13. (New) Article as claimed in claim 12, wherein said layer has a rhombohedral perovskite structure.
- 14. (New) Article as claimed in claim 12, wherein said layer has an average dielectric constant value in the range between 15 and 35.
- 15. (New) Article as claimed in claim 12, wherein x is greater than 0.07.
- 16. (New) Article as claimed in claim 12, wherein x is less than 0.4.